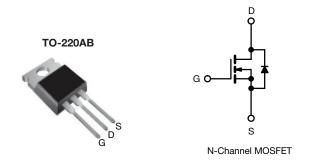
Vishay Siliconix

# **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	1.5		
Q <sub>g</sub> max. (nC)	38			
Q <sub>gs</sub> (nC)	5.0			
Q <sub>gd</sub> (nC)	22			
Configuration	Single			



#### **FEATURES**

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- · Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

## Note

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details.

## **DESCRIPTION**

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF830PbF		
Lead (Pb)-free	SiHF830-E3		
SnPb	IRF830		
SIPD	SiHF830		

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	500	V	
Gate-Source Voltage			$V_{GS}$	± 20	<b></b>	
Continuous Prain Current	V -140V	T <sub>C</sub> = 25 °C		4.5		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	2.9	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	18		
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy b			E <sub>AS</sub>	280	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	4.5	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	7.4	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			$P_{D}$	74	W	
Peak Diode Recovery dV/dt c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering Recommendations (Peak temperature) d for 10 s			_	300		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

## **Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=50~V$ , starting  $T_J=25~^{\circ}C$ , L=24~mH,  $R_g=25~\Omega$ ,  $I_{AS}=4.5~A$  (see fig. 12).
- c.  $I_{SD} \le 4.5$  A,  $dI/dt \le 75$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.



# Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	$R_{thJA}$	-	62			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.7			

PARAMETER	SYMBOL	TEST	TEST CONDITIONS		TYP.	MAX.	UNIT
Static		•					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 1 mA	-	0.61	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = '	$V_{GS}$ , $I_{D} = 250 \mu\text{A}$	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V	<sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zan Oala Valla a Buria Oamal		V <sub>DS</sub> = {	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$		-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 400 \text{ V},$	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.7 A <sup>b</sup>	-	-	1.5	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = \xi$	50 V, I <sub>D</sub> = 2.7 A <sup>b</sup>	2.5	-	-	S
Dynamic		•			•	•	
Input Capacitance	C <sub>iss</sub>	,	$V_{GS} = 0 \text{ V},$	-	610	-	
Output Capacitance	C <sub>oss</sub>	\	$I_{DS} = 25 \text{ V},$	-	160	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0	MHz, see fig. 5	-	68	-	1
Total Gate Charge	Qg			1	-	38	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 3.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 b	-	-	5.0	
Gate-Drain Charge	Q <sub>gd</sub>		See lig. 0 and 15	-	-	22	
Turn-On Delay Time	t <sub>d(on)</sub>			1	8.2	-	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 250 V, $I_{D}$ = 3.1 A $R_{g}$ = 12 $\Omega$ , $R_{D}$ = 79 $\Omega$ , see fig. 10 $^{b}$		-	16	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	42	-	
Fall Time	t <sub>f</sub>			-	16	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") fro	Between lead, 6 mm (0.25") from package and center of die contact		4.5	-	- LI
Internal Source Inductance	L <sub>S</sub>	· -			7.5	-	- nH
Gate Input Resistance	$R_g$	f = 1 MHz, open drain		0.5	-	2.7	Ω
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symb showing the	MOSFET symbol showing the		-	4.5	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	18	- A
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25  ^{\circ}\text{C},  I_S = 4.5  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.1 A, dl/dt = 100 A/μs b		-	320	640	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	1.0	2.0	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$				L <sub>D</sub> )	

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

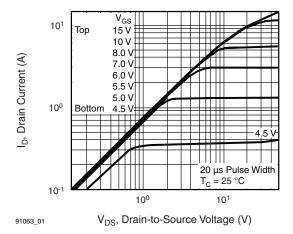


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

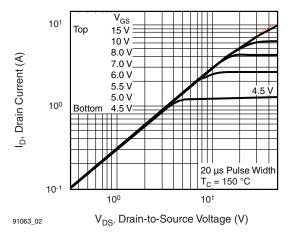


Fig. 2 - Typical Output Characteristics,  $T_C = 150 \, ^{\circ}\text{C}$ 

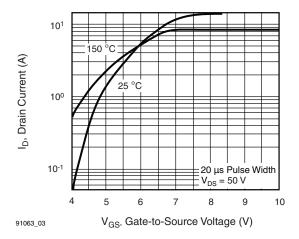


Fig. 3 - Typical Transfer Characteristics

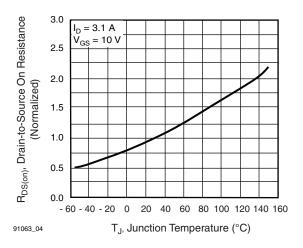


Fig. 4 - Normalized On-Resistance vs. Temperature

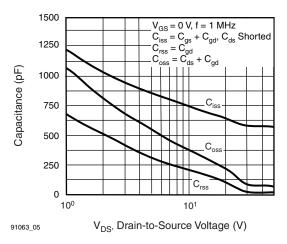


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

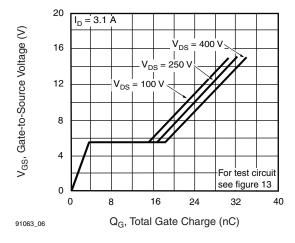


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage



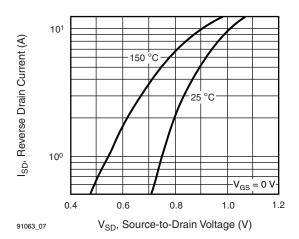


Fig. 7 - Typical Source-Drain Diode Forward Voltage

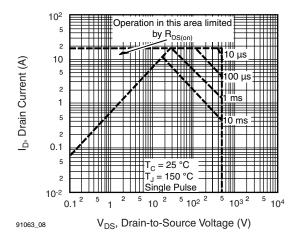


Fig. 8 - Maximum Safe Operating Area

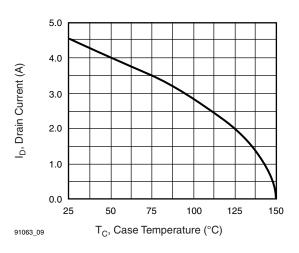


Fig. 9 - Maximum Drain Current vs. Case Temperature

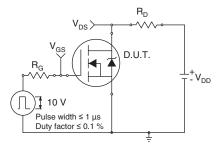


Fig. 10a - Switching Time Test Circuit

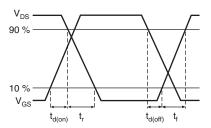


Fig. 10b - Switching Time Waveforms

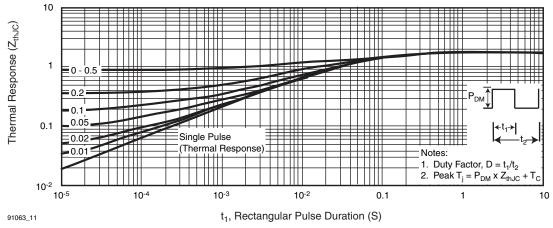


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



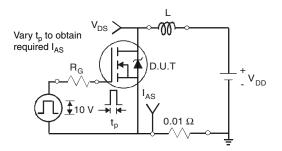


Fig. 12a - Unclamped Inductive Test Circuit

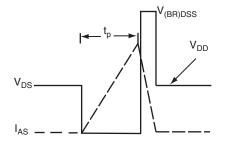


Fig. 12b - Unclamped Inductive Waveforms

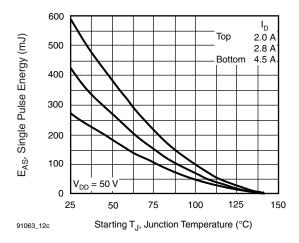


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

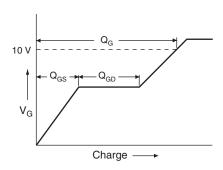


Fig. 13a - Basic Gate Charge Waveform

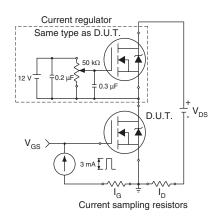
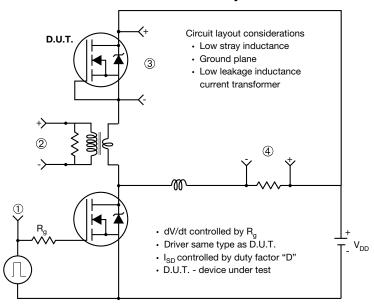


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



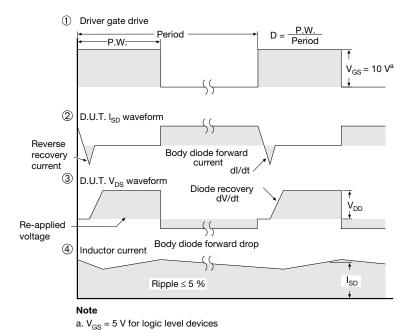
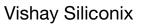


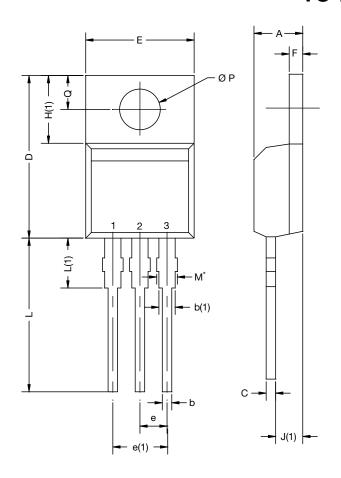
Fig. 14 - For N-Channel

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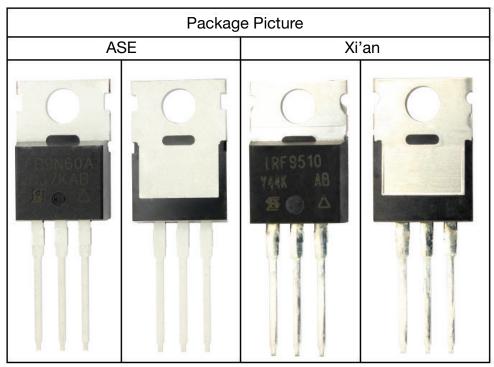
# TO-220-1



DIM.	MILLIM	IETERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
E	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØΡ	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031					

## Note

 $\bullet$   $M^{\star}=0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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Vishay

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